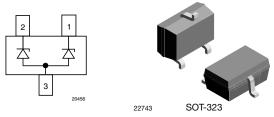
VESD01A2-03G to VESD33A2-03G

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Dual-Line ESD-Protection Diode Array in SOT-323



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MARKING (example only)



22744

ABC = type code (see table below) WW = date code working week VY = date code year

LINKS TO ADDITIONAL RESOURCES



FEATURES

- Compact SOT-323 package
- 2-line unidirectional ESD-protection
- AEC-Q101 qualified available
- Working range 1 V to 33 V
- ESD immunity acc. IEC 61000-4-2 ±15 kV to ±30 kV contact discharge ±15 kV to ±30 kV air discharge
- Lead plating: Sn (e3) - soldering can be checked by standard vision
 - inspection - AOI = Automated Optical Inspection
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

ORDERING INFORMATION							
		ENVIRONMENTAL AND QUALITY CODE					
PART NUMBER (EXAMPLE)	AEC-Q101 QUALIFIED	RoHS COMPLIANT + LEAD (Pb)-FREE TERMINATIONS	TIN PLATED	8K PER 7" REEL (8 mm TAPE)	ORDERING CODE (EXAMPLE)		
		GREEN		MOQ = 8K/BOX			
VESD05A2-03G	-	G	3	-08	VESD05A2-03G-G3-08		
VESD05A2-03G	Н	G	3	-08	VESD05A2-03GHG3-08		

PACKAGE DAT	Ά					
DEVICE NAME	PACKAGE NAME	TYPE CODE	WEIGHT	MOLDING COMPOUND FLAMMABILITY RATING	MOISTURE SENSITIVITY LEVEL	SOLDERING CONDITIONS
VESD01A2-03G-G3	SOT-323	D01				
VESD03A2-03G-G3	SOT-323	D03				
VESD05A2-03G-G3	SOT-323	D05				
VESD08A2-03G-G3	SOT-323	D08			MSL level 1	Deals temporature may 060 °C
VESD12A2-03G-G3	SOT-323	D12	5.2 mg	UL 94 V-0	(according J-STD-020)	Peak temperature max. 260 °C
VESD16A2-03G-G3	SOT-323	D16				
VESD26A2-03G-G3	SOT-323	D26	1			
VESD33A2-03G-G3	SOT-323	D33	1			





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ABSOLUTE MAXIMUM RATINGS VESD01A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)					
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT	
Peak pulse current	Acc. IEC 61000-4-5, 8/20 µs/single shot	I _{PPM}	11	А	
Peak pulse power	Acc. IEC 61000-4-5, 8/20 µs/single shot	P _{PP}	70	W	
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	M	30	kV	
	Air discharge acc. IEC 61000-4-2; 10 pulses	V _{ESD}	30	kV	
Operating temperature	Junction temperature	TJ	-55 to +150	°C	
Storage temperature		T _{stg}	-55 to +150	°C	

ABSOLUTE MAXIMUM RATINGS VESD03A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)				
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT
Peak pulse current	Acc. IEC 61000-4-5, 8/20 µs/single shot	I _{PPM}	11.6	А
Peak pulse power	Acc. IEC 61000-4-5, 8/20 µs/single shot	P _{PP}	100	W
	Contact discharge acc. IEC 61000-4-2; 10 pulses	M	30	kV
ESD immunity	Air discharge acc. IEC 61000-4-2; 10 pulses	V _{ESD}	30	kV
Operating temperature	Junction temperature	TJ	-55 to +150	°C
Storage temperature		T _{stg}	-55 to +150	°C

ABSOLUTE MAXIMUM RATINGS VESD05A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)					
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT	
Peak pulse current	Acc. IEC 61000-4-5, 8/20 µs/single shot	I _{PPM}	8.7	A	
Peak pulse power	Acc. IEC 61000-4-5, 8/20 µs/single shot	P _{PP}	100	W	
	Contact discharge acc. IEC 61000-4-2; 10 pulses	M	30	kV	
ESD immunity	Air discharge acc. IEC 61000-4-2; 10 pulses	V _{ESD}	30	kV	
Operating temperature	Junction temperature	TJ	-55 to +150	°C	
Storage temperature		T _{stg}	-55 to +150	°C	

ABSOLUTE MAXIMUM RATINGS VESD08A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)					
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT	
Peak pulse current	Acc. IEC 61000-4-5, 8/20 µs/single shot	I _{PPM}	6.60	А	
Peak pulse power	Acc. IEC 61000-4-5, 8/20 µs/single shot	P _{PP}	100	W	
	Contact discharge acc. IEC 61000-4-2; 10 pulses	M	30	kV	
ESD immunity	Air discharge acc. IEC 61000-4-2; 10 pulses	V _{ESD}	30	kV	
Operating temperature	Junction temperature	TJ	-55 to +150	°C	
Storage temperature		T _{stg}	-55 to +150	°C	



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ABSOLUTE MAXIMUM RATINGS VESD12A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)				
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT
Peak pulse current	Acc. IEC 61000-4-5, 8/20 µs/single shot	I _{PPM}	4.4	A
Peak pulse power	Acc. IEC 61000-4-5, 8/20 µs/single shot	P _{PP}	100	W
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	V	30	kV
ESD initiality	Air discharge acc. IEC 61000-4-2; 10 pulses	V _{ESD}	30	kV
Operating temperature	Junction temperature	TJ	-55 to +150	°C
Storage temperature		T _{stg}	-55 to +150	°C

ABSOLUTE MAXIMUM RATINGS VESD16A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)					
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT	
Peak pulse current	Acc. IEC 61000-4-5, 8/20 µs/single shot	I _{PPM}	3.6	А	
Peak pulse power	Acc. IEC 61000-4-5, 8/20 µs/single shot	P _{PP}	100	W	
ESD immunity	Contact discharge acc. IEC 61000-4-2; 10 pulses	M	30	kV	
	Air discharge acc. IEC 61000-4-2; 10 pulses	V _{ESD}	30	kV	
Operating temperature	Junction temperature	TJ	-55 to +150	°C	
Storage temperature		T _{stg}	-55 to +150	°C	

ABSOLUTE MAXIMUM RATINGS VESD26A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)				
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT
Peak pulse current	Acc. IEC 61000-4-5, 8/20 µs/single shot	I _{PPM}	2.1	А
Peak pulse power	Acc. IEC 61000-4-5, 8/20 µs/single shot	P _{PP}	100	W
	Contact discharge acc. IEC 61000-4-2; 10 pulses	M	20	kV
ESD immunity	Air discharge acc. IEC 61000-4-2; 10 pulses	V _{ESD}	20	kV
Operating temperature	Junction temperature	TJ	-55 to +150	°C
Storage temperature		T _{stg}	-55 to +150	°C

ABSOLUTE MAXIMUM RATINGS VESD33A2-03G T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)					
PARAMETER	TEST CONDITIONS	SYMBOL	VALUE	UNIT	
Peak pulse current	Acc. IEC 61000-4-5, 8/20 µs/single shot	I _{PPM}	1.6	А	
Peak pulse power	Acc. IEC 61000-4-5, 8/20 µs/single shot	P _{PP}	100	W	
	Contact discharge acc. IEC 61000-4-2; 10 pulses	M	15	kV	
ESD immunity	Air discharge acc. IEC 61000-4-2; 10 pulses	V _{ESD}	15	kV	
Operating temperature	Junction temperature	TJ	-55 to +150	°C	
Storage temperature		T _{stg}	-55 to +150	°C	

VESD01A2-03G to VESD33A2-03G



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	CTERISTICS VESD01A2-03G vin 1 - 3 or 2 - 3, unless otherwise sp	ecified)				
PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines
Reverse stand off voltage	Max. reverse working voltage	V _{RWM}	-	-	1	V
Reverse voltage	at I _R = 100 μA	V _R	1	1.2	-	V
Reverse current	at V _R = 1 V	I _R	-	20	100	μA
Reverse breakdown voltage	at I _R = 20 mA	V _{BR}	2.5	2.65	2.8	V
Reverse clamping voltage	at $I_{PP} = I_{PPM} = 11 \text{ A}$, $t_p = 8/20 \mu\text{s}$	V _C	-	5.6	6.4	V
Forward clamping voltage	at $I_{PP} = 1 \text{ A}$, $t_p = 300 \mu\text{s}$	V _F	0.9	1.1	1.2	V
Forward clamping voltage	at I _{PP} = I _{PPM} = 11 A, t _p = 8/20 μs	V _F	-	2.5	3.2	V
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	0.13	-	Ω
Capacitance	at $V_R = 0 V$; f = 1 MHz	CD	153	192	230	pF

ELECTRICAL CHARACTERISTICS VESD03A2-03G

 $(T_{amb} = 25 \degree C, between pin 1 - 3 or 2 - 3, unless otherwise specified)$

PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines
Reverse stand off voltage	Max. reverse working voltage	V _{RWM}	-	-	3	V
Reverse voltage	at I _R = 20 μA	V _R	3	-	-	V
Reverse current	at V _R = 3 V	I _R	-	8	20	μA
Reverse breakdown voltage	at I _R = 1 mA	V _{BR}	4.4	4.65	4.9	V
Reverse clamping voltage	at I _{PP} = I _{PPM} = 11.6 A, t _p = 8/20 μs	V _C	-	7.8	8.70	V
	at I _{PP} = 1 A, t _p = 300 μs	V _F	0.9	1.1	1.2	V
Forward clamping voltage	at I _{PP} = I _{PPM} = 11.6 A, t _p = 8/20 μs	V _F	-	2.6	3.32	V
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	0.19	-	Ω
Capacitance	at V _R = 0 V; f = 1 MHz	CD	89	112	135	pF

ELECTRICAL CHARACTERISTICS VESD05A2-03G

(T_{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)

PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines
Reverse stand off voltage	Max. reverse working voltage	V _{RWM}	-	-	5	V
Reverse voltage	at I _R = 1 μA	V _R	5	-	-	V
Reverse current	at V _R = 5 V	I _R	-	0.01	0.1	μA
Reverse breakdown voltage	at I _R = 1 mA	V _{BR}	6.85	7.26	7.65	V
Reverse clamping voltage	at $I_{PP} = I_{PPM} = 8.7 \text{ A}, t_p = 8/20 \ \mu \text{s}$	V _C	-	10.3	11.5	V
Forward clamping voltage	at I _{PP} = 1 A, t _p = 300 μs	V _F	0.9	1.1	1.2	V
	at $I_{PP} = I_{PPM} = 8.7 \text{ A}, t_p = 8/20 \ \mu \text{s}$	V _F	-	2.2	2.74	V
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	0.2	-	Ω
Capacitance	at $V_R = 0 V$; f = 1 MHz	CD	53	67	81	pF





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ELECTRICAL CHARACTERISTICS VESD08A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)							
PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines	
Reverse stand off voltage	Max. reverse working voltage	V _{RWM}	-	-	8	V	
Reverse voltage	at I _R = 0.1 μA	V _R	8	-	-	V	
Reverse current	at V _R = 8 V	I _R	-	0.01	0.1	μA	
Reverse breakdown voltage	at I _R = 1 mA	V _{BR}	9.5	10	10.5	V	
Reverse clamping voltage	at $I_{PP} = I_{PPM} = 6.6 \text{ A}, t_p = 8/20 \ \mu\text{s}$	V _C	-	13.7	15.3	V	
Forward clamping voltage	at I _{PP} = 1 A, t _p = 300 μs	V _F	0.9	1.1	1.2	V	
	at $I_{PP} = I_{PPM} = 6.6 \text{ A}, t_p = 8/20 \mu\text{s}$	V _F	-	1.9	2.32	V	
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	0.23	-	Ω	
Capacitance	at $V_R = 0 V$; f = 1 MHz	CD	37	47	57	pF	

ELECTRICAL CHARACTERISTICS VESD12A2-03G

 $(T_{amb} = 25 \degree C, between pin 1 - 3 or 2 - 3, unless otherwise specified)$

PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines
Reverse stand off voltage	Max. reverse working voltage	V _{RWM}	-	-	12	V
Reverse voltage	at I _R = 0.1 μA	V _R	12	-	-	V
Reverse current	at V _R = 12 V	I _R	-	0.01	0.1	μA
Reverse breakdown voltage	at I _R = 1 mA	V _{BR}	13.9	14.7	15.5	V
Reverse clamping voltage	at I _{PP} = I _{PPM} = 4.4 A, t _p = 8/20 µs	V _C	-	20.5	22.7	V
Forward clamping voltage	at $I_{PP} = 1 \text{ A}$, $t_p = 300 \ \mu \text{s}$	V _F	0.9	1.1	1.2	V
	at I _{PP} = I _{PPM} = 4.4 A, t _p = 8/20 µs	V _F	-	1.6	1.88	V
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	0.4	-	Ω
Capacitance	at V _R = 0 V; f = 1 MHz	CD	26	33	40	pF

ELECTRICAL CHARACTERISTICS VESD16A2-03G

(T_{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)

PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines
Reverse stand off voltage	Max. reverse working voltage	V _{RWM}	-	-	16	V
Reverse voltage	at I _R = 0.1 μA	V _R	16	-	-	V
Reverse current	at V _R = 16 V	I _R	-	0.01	0.1	μA
Reverse breakdown voltage	at I _R = 1 mA	V _{BR}	17	17.9	18.8	V
Reverse clamping voltage	at $I_{PP} = I_{PPM} = 3.6 \text{ A}, t_p = 8/20 \mu\text{s}$	V _C	-	25.3	28	V
Forward clamping voltage	at I _{PP} = 1 A, t _p = 300 μs	V _F	0.9	1.1	1.2	V
	at $I_{PP} = I_{PPM} = 3.6 \text{ A}, t_p = 8/20 \mu\text{s}$	V _F	-	1.5	1.72	V
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	0.53	-	Ω
Capacitance	at $V_R = 0 V$; f = 1 MHz	CD	21	27	33	pF





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	CTERISTICS VESD26A2-03G pin 1 - 3 or 2 - 3, unless otherwise sp	ecified)				
PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines
Reverse stand off voltage	Max. reverse working voltage	V _{RWM}	-	-	26	V
Reverse voltage	at I _R = 0.1 μA	V _R	26	-	-	V
Reverse current	at V _R = 26 V	I _R	-	< 0.01	0.1	μA
Reverse breakdown voltage	at I _R = 1 mA	V _{BR}	27.6	29.1	30.6	V
Reverse clamping voltage	at $I_{PP} = I_{PPM} = 2.1 \text{ A}$, $t_p = 8/20 \ \mu s$	V _C	-	43	48	V
Forward elemping voltage	at $I_{PP} = 1 \text{ A}$, $t_p = 300 \mu\text{s}$	V _F	0.9	1.1	1.2	V
Forward clamping voltage	at $I_{PP} = I_{PPM} = 2.1 \text{ A}, t_p = 8/20 \ \mu \text{s}$	V _F	-	1.3	1.42	V
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	1.9	-	Ω
Capacitance	at $V_R = 0 V$; f = 1 MHz	CD	14	17.5	21	pF

ELECTRICAL CHARACTERISTICS VESD33A2-03G (T _{amb} = 25 °C, between pin 1 - 3 or 2 - 3, unless otherwise specified)							
PARAMETER	TEST CONDITIONS/REMARKS	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Protection paths	Number of lines which can be protected	N _{channel}	-	-	2	lines	
Reverse stand off voltage	Max. reverse working voltage	V _{RWM}	-	-	33	V	
Reverse voltage	at I _R = 0.1 μA	V _R	33	-	-	V	
Reverse current	at V _R = 33 V	I _R	-	< 0.01	0.1	μA	
Reverse breakdown voltage	at I _R = 1 mA	V _{BR}	35.5	37.4	39.3	V	
Reverse clamping voltage	at $I_{PP} = I_{PPM} = 1.6 \text{ A}, t_p = 8/20 \ \mu \text{s}$	V _C	-	56	62.5	V	
Forward clamping voltage	at I _{PP} = 1 A, t _p = 300 μs	V _F	0.9	1.1	1.2	V	
	at $I_{PP} = I_{PPM} = 1.6 \text{ A}, t_p = 8/20 \ \mu \text{s}$	V _F	-	1.22	1.32	V	
Dynamic resistance	t _p = 100 ns (TLP; reverse direction)	r _{dyn}	-	3.6	-	Ω	
Capacitance	at $V_R = 0 V$; f = 1 MHz	CD	12	15	18	pF	

VESD01A2-03G to VESD33A2-03G

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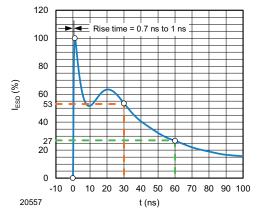


Fig. 1 - ESD Discharge Current Wave Form acc. IEC 61000-4-2 (330 Ω / 150 pF)

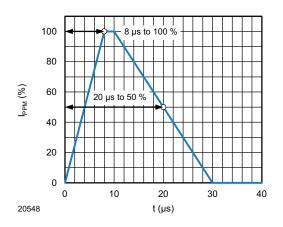


Fig. 2 - 8/20 µs Peak Pulse Current Wave Form acc. IEC 61000-4-5

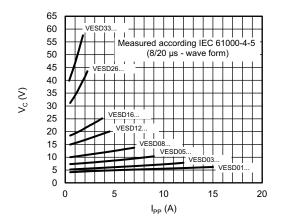


Fig. 3 - Typical Peak Clamping Voltage vs. Peak Pulse Current

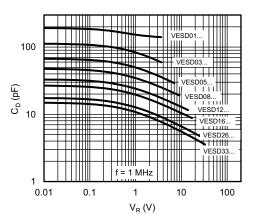


Fig. 4 - Typical Capacitance vs. Reverse Voltage

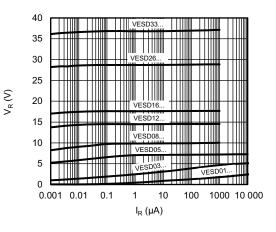


Fig. 5 - Typical Reverse Voltage vs. Reverse Current

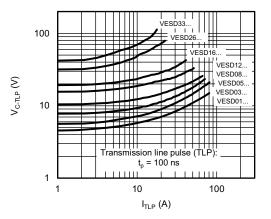


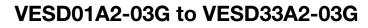
Fig. 6 - Typical Clamping Voltage vs. Peak Pulse Current

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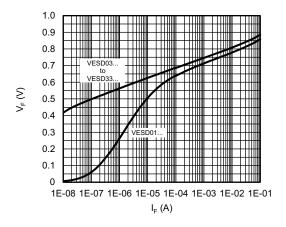
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Fig. 7 - Typical Forward Voltage vs. Forward Current

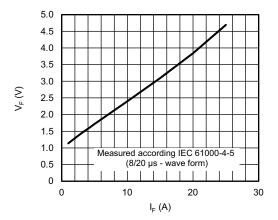
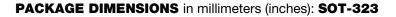
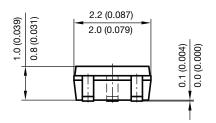
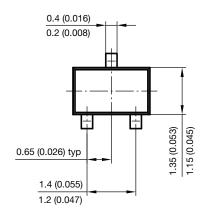


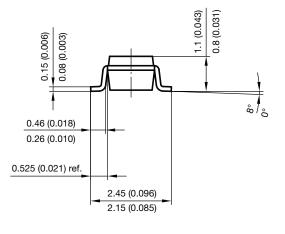
Fig. 8 - Typical Forward Voltage vs. Forward Current



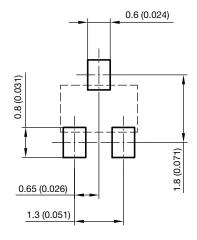




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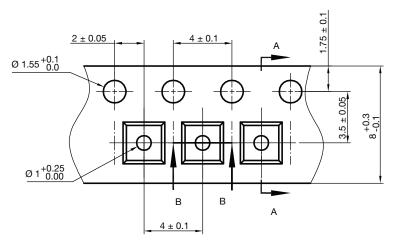


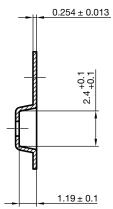
VESD01A2-03G to VESD33A2-03G

A-A Section

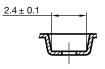
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CARRIER TAPE SOT-323



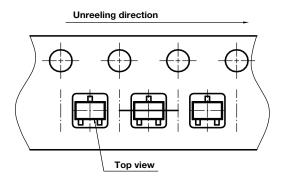


B-B Section



Document no.: S8-V-3717.08-002 (4) Created - Date: 09. Feb. 2010 22762

ORIENTATION IN CARRIER TAPE SOT-323



Document no.: S8-V-3717.08-002 (4) Created - Date: 09. Feb. 2010 22761

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